## Application/Control No. Applicant(s)/Patent Under Reexamination 10/511,097 **UENO ET AL.** Notice of References Cited Examiner Art Unit Page 1 of 1 Mark A. Chapman 1756 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-6,409,812 06-2002 Ueno et al. 106/31.51 Α US-5,786,523 07-1998 Ueno et al. 568/735 В US-С US-D US-Ε F US-US-G US-Н ١ US-US-US-Κ US-L US-М FOREIGN PATENT DOCUMENTS Document Number Date Classification Country Code-Number-Kind Code Country Name MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

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